

Notice of References Cited	Application/Control No. 10/804,171		Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Douglas J. Duff		Art Unit 3748	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0143083	07-2003	Hix et al.	417/221
*	B	US-6,132,177	10-2000	Loprete et al.	417/221
*	C	US-6,755,624	06-2004	Bae et al.	417/221
*	D	US-6,619,926	09-2003	Manole et al.	417/53
*	E	US-6,217,287	04-2001	Monk et al.	417/45
*	F	US-4,479,419	10-1984	Wolfe, Robert W.	92/13.3
*	G	US-4,236,874	12-1980	Sisk, Francis J.	417/315
*	H	US-2002/0051715	05-2002	Matsumoto et al.	417/410.3
*	I	US-2003/0143083	07-2003	Hix et al.	417/221
*	J	US-2003/0049136	03-2003	Manole et al.	417/53
*	K	US-5,780,990	07-1998	Weber, Harold J.	318/807
*	L	US-5,006,051	04-1991	Hattori, Hitoshi	418/60
*	M	US-5,322,424	06-1994	Fujio, Katuhara	418/11

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.